A Data-Model for a Technology and Simulation Archive

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Abstract

In this paper, we describe software aimed at achieving a significant reduction in the time required to develop new semiconductor technologies, by facilitating simulation sharing, and recognition and reuse of technology modules. We have created a technology and simulation archive based on the World-Wide Web (WWW) data-model. The WWW data-model is very flexible in capturing the wide variety of data formats of technology and simulation related information, and it proves to be sufficiently fast for frequent direct data retrieval by simulation tools.

1. Introduction

In a typical design environment for semiconductor technology, engineers of many different skill levels have to navigate through a wide variety of data (simulations, experiments, process flows, etc.) from many different sources.¹

A rigid data-base approach for storage and retrieval of predefined objects is too inflexible to capture our needs:

- facilitate storage, retrieval and reuse of calibrated simulation know-how (input decks, experimental/simulation results, hints and documentation)
- make process flows and recipes directly accessible by simulators
- allow engineers of all levels to acquaint themselves with the technologies and simulation capabilities.

Here we present a complete departure from traditional data bases: An **archive** which is based on the **World-Wide Web** (WWW) **data-model** [1]. The WWW datamodel is a distributed hypermedia system which allows many possible relations (*using hypertext links* and *index searches*) between any individual objects and others. Each object can be any type of data file that can be stored on a computer.

 $^{^{1}}$ Although there are excellent proposals for a unified data exchange format (e.g. [2]) such a format has not become generally established.

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2. Implementation

To use the WWW data-model, one has to set up servers for the http [1] and wais [3] protocols and to install clients (commonly refered to as browsers) for requesting data from the servers. In this section we focus on selected features in the the WWW data-model which significantly improve its capabilities for a technology and simulation archive.

A browser (most popular browsers are Mosaic and Netscape) needs to know what to do with the data being requested. In order to handle this, each file in the archive is assigned an explicit **content-type** [4]. When a browser requests an object, the server returns the object's content together with its content-type.² Depending on the content-type the browser performs **actions** to view the object. This action, in many cases, is just the presentation in the document window of the browser, but we have found it to be very beneficial to include transformation of the data-formats and spawning of external viewers.

The archive is easily extended to include additional data types by creating a mailcap [5] entry in the browser's .mailcap file to associate the content type with the program to view it. For instance, as shown in Figure 1, tonyplot is used to view results from Silvaco [6] simulators.

For each object in the archive a **description** is entered. This description is displayed during directory-based browsing to help the user to identify the object. Furthermore we plan to index the descriptions to allow searches.

During check-in of an object into the archive, both the content-type and the description are entered into a local .htaccess file. Additionally, new hyperlinks need to be created and indexes need to be updated by corresponding routines on the server.

Uploading of new information and other administrative functions are performed by http-POSTs to WWW-agents (CGI-script [7]) from either the browser (using HTML-forms [8]) or separate programs (Figure 2).



Figure 1: In the browsers' mailcap file content-types and corresponding viewing actions are specified.



Figure 2: Uploading data to the server is performed by http-POST to WWW-agents (CGI-scripts).

Proprietary information is **protected** by a combination of (i) access restriction by domain (Internet address of client), and (ii) a simple user authentication scheme (userid, password) using X.500 directory [7] services. Eventually encryption schemes such as PGP [9] will be included for transfers to off-site locations.

3. Utilization

We have used the WWW data-model to build up a technology and simulation archive which we call the "Simulation and Technology Information Discovery and Access System" (Figure 3). Currently our system provides for browsing (hyperlinked, directory based, and search-able through free text and fielded indexes) of the following kind of semiconductor technology related data:

 $^{^{2}}$ Actually, the browser negotiates the acceptable content-types with the server

- Calibrated process and device simulations (input files, results, etc.) for, e.g., PowerPC, fast SRAM (4Mbit, 16Mbit, 64Mbit), non-volatile memory (Flash, EE, 1T, 1.5T cell). These simulations are intended for reuse and to demonstrate current simulation capabilities.
- For simulation automation tools (see below) as well as for training and discovery learning, process flows hyperlinked to miniflows and to technology cross-sections at key steps in the process; individual recipes (miniflows) and masksets.
- Solutions to recurrent simulation issues (e.g. shallow trench and PELOX isolation)
- Manuals, examples and helpful hints
- WAIS index of U.S. patent abstracts; to follow projects complete index of Sematech and SRC abstracts; technical reports, table of contents of selected journals, etc.

We store process flow representation (**PFR**) and recipe (**miniflow**) information in the original format as generated by the **CIM-system** [10], which is **familiar to the engineers**. We have developed a set of supporting flow-to-<simulator> tools which translate the PFRs, mask information, and the miniflows into valid simulation input files (Figure 4). The individual tools can be used from the command-line or from VISTA [11] to perform standard device characterizations. The fact that the application engineers now have only to deal with the familiar PFR greatly enhanced the **acceptance** of advanced simulators.

Each recipe referenced by the PFR (Figure 5) is stored in a **miniflow** file (Figure 6). The miniflows from the CIM-environment are represented together with process simulator commands to capture knowledge from previous experience. To account for the variety of process simulators (1D vs. 2D, different vendors) the miniflow's command lines are translated to the individual simulator syntax. To adopt to specific process simulator requirements we use cpp-like extensions in the miniflows. The masks referenced in the PFR are stored in a maskset file. For each mask and each device cross-section the information about covered and exposed areas is stored in parameterized form (Figure 7).

An issue is the average response time of the server during **frequent accesses** to the archive. The above mentioned translation process by the the flow-to-<simulator> tools requires to access several hundred objects from the archive server. We experienced, that the response time of the server is short enough to translate typical PFRs into simulator-input files within a few seconds. I.e., the WWW data-model is sufficiently fast for frequent direct data retrieval by simulation tools.

4. Conclusion

We have created a technology and simulation archive based on the WWW data-model. The WWW data-model proved its efficiency and flexibility in capturing the wide variety of data formats of technology and simulation related information. Technology knowledge, including simulation, can be **collectively** built up and made available to **individuals**. Due to its open configuration with hyperlinks and index searches, the archive is the perfect environment for **discovery learning** for users of all skill levels. Additionally, the WWW provides a convenient platform for technology transfer while complying with security directives.

References

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Figure 3: Example *home page*, the front door to APRDL Simulation and Technology Information Discovery & Access System.



Figure 4: Flow-to-<simulator> tools create input files for various simulators from original CIM-syntax.

• • • •		M	ask # 🖳	•	
14	active	PR		 (P05)	PRxy1A
15	active	nit et	ch 1400A		ERxy2M
16	n-chan	field	PR	P06	PRxy1A
17	n-chan	field	implant	B,100keV,1.0e13	IMxy3
18	n-chan	field	PR strip		ERxy4
19	field d	drive/c	x	_	DXYSB)
• • • •			Mi	niflow ref#	

Figure 5: Example PFR generated by the CIM-equipment [10]. The process shown is from [12].

###	Miniflow: Dx	y5B - Field	Drive & Oxidation				
#	Push	0:10:00	800 degC N2+2%02				
#	Ramp	0:12:00	1000 degC N2+2%O2				
#	Drive	2:00:00	1000 degC N2+2%02				
#	Oxidize	3:10:00	1000 degC 02+H2				
#	Ramp	0:40:00	800 degC N2				
#	Pull	0:15:00	800 degC N2				
diff	f time=120	temp=1000	dry pressure=0.0196				
#if(lef Athena						
method viscous oxide.rel=5e-3 grid.oxide=0.05							
#enc	lif						
diff	f time=190	temp=1000	wet pressure=0.85				

Figure 6: Example of a miniflow file, showing recipe [12], generic simulator commands and simulator specific extensions.

Mas	k#								
(P01) pmosT	# 1	'his	regio	n left	bare	after	PR		
device-cross-section									
P05 (nmosT)	depos	sit p	hotor	es thi	.ckness	s=1.000	00		
P05_nmosT	etch	phot	ores	left	x= <ler< td=""><td>ngth1></td><td></td></ler<>	ngth1>			
P05_nmosT	etch	phot	ores	right	x= <ler< td=""><td>ngth2></td><td></td></ler<>	ngth2>			

Figure 7: Maskset: specifies the covered and exposed areas for each mask and device.